

Application/Control No.	Applicant(s)/Patent under Reexamination
10/699,094	NIEHOFF ET AL.
Examiner	Art Unit
Con P. Tran	2615

OEA DOUED						
	SEARCHED					
Class	Subclass	Date	Examiner			
381	110	3/15/2007	СРТ			
704	251,231	3/15/2007	CPT			
	246	3/15/2007	CPT			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EIC/PLUS	1/4/2007	СРТ
Vivian Chin	3/8/2007	CPT
EAST (US-PGPUB, USPT, USOCR,) - See Search History Printout	3/19/2007	СРТ
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